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(Rev. 7-83)U.S. Department of Commerce
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5833-A-11

SERIAL NO. 09/575,298

INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

APPLICANT: ELENIOUS, PETER ET AL.

FILING DATE
May 19, 2000

GROUP 1725

#2

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	EXHIBIT NUMBER	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
<i>RE</i>	—	5,220,200	6/15/93	Blanton	—	—	—
<i>RE</i>	—	5,261,593	11/16/93	Casson, et al.	—	—	—
<i>RE</i>	—	5,547,740	8/20/96	Higdon, et al.	—	—	—
<i>RE</i>	—	5,564,617	10/15/96	Degani, et al.	—	—	—

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	EXHIBIT NUMBER	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

<i>RE</i>	—	Brakke, Kenneth A., Mathematics Department, Susquehanna University, Selinsgrove, PA 17870, excerpts from the Web site for "The Surface Evolver", Version 2.14, dated August 18, 1999, including Surface Evolver Overview; Surface Evolver Documentation: Example: Column of Liquid Solder; Newsletter No. 2 (2/26/93); and Newsletter No. 8 (6/23/94).
<i>RE</i>	—	Brandenburg, Scott and Yeh, Shing, "Electromigration Studies Of Flip Chip Bump Solder Joints", <i>Proceedings Surface Mount International 1998</i> , September 1998.

EXAMINER

Nitin Parikh

DATE CONSIDERED

09/25/01

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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APPLICANT: ELENUS, PETER ET AL.

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U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	EXHIBIT NUMBER	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
12	—	5,367,435	11/22/94	Andros et al.			
12	—	6,239,488	5/29/01	Chen			

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JAN 29 2002
TC 2800 MAIL ROOM

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	EXHIBIT NUMBER	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER

N. P. Parekh

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